

Features

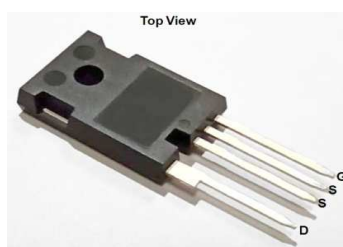
- CRM(CQ) Super_Junction technology
- Much lower $R_{on} \cdot A$ performance for On-state efficiency
- Better efficiency due to very low FOM

Applications

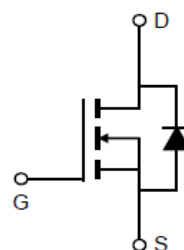
- LED/LCD/PDP TV and monitor Lighting
- Solar/Renewable/UPS-Micro Inverter System
- Charger
- Power Supply

Product Summary

V_{DS}	650V
$R_{DS(on)_{typ}}$	40mΩ
I_D	83A

100% DVDS Tested
100% Avalanche Tested


CRJQF41N65GC


Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRJQF41N65GC	-	TO-247-4L	Tube	N/A	N/A	30pcs

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	650	V
Continuous drain current $T_C = 25^\circ\text{C}$ $T_C = 100^\circ\text{C}$	I_D	83 52	A
Pulsed drain current ($T_C = 25^\circ\text{C}$, t_p limited by T_{jmax})	$I_{D \text{ pulse}}$	331	A
Avalanche energy, single pulse ($L=30\text{mH}$, $R_g=30\Omega$)	E_{AS}	1500	mJ
Gate-Source voltage	V_{GS}	± 30	V
Power dissipation ($T_C = 25^\circ\text{C}$)	P_{tot}	658	W
Operating junction and storage temperature	T_j, T_{stg}	-55...+150	$^\circ\text{C}$

Thermal Resistance

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Thermal resistance, junction - case. Max	RthJC	-	0.1357	0.19	°C/W	
Thermal resistance, junction - ambient. Max	RthJA	-	-	43	°C/W	

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV _{DSS}	650	-	-	V	V _{GS} =0V, I _D =250uA
Gate threshold voltage	V _{GS(th)}	3.2	-	4.2	V	V _{DS} =V _{GS} , I _D =250uA
Zero gate voltage drain current	I _{DSS}	-	-	2	μA	V _{DS} =650V, V _{GS} =0V
		-	10	-		T _C =25°C T _C =150°C
Gate-source leakage current	I _{GSS}	-	-	±100	nA	V _{GS} =±30V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	40	46	mΩ	V _{GS} =10V, I _D =35A,
		-	100	-		T _C =25°C T _C =150°C
Transconductance	g _{fs}	-	63	-	S	V _{DS} =20V, I _D =35A

Dynamic Characteristic

Input Capacitance	C _{iss}	-	7580	11370	pF	V _{GS} =0V, V _{DS} =100V, f=1MHz
Output Capacitance	C _{oss}	-	250	375		
Reverse Transfer Capacitance	C _{rss}	-	35	70		
Gate Total Charge	Q _G	-	213	320	nC	V _{GS} =10V, V _{DS} =480V, I _D =35A, f=1MHz
Gate-Source charge	Q _{gs}	-	37	74		
Gate-Drain charge	Q _{gd}	-	82	164		
Turn-on delay time	t _{d(on)}	-	146	-	ns	T _J =25°C, V _{GS} =10V, I _D =35A, V _{DS} =400V, R _g =27 Ω
Rise time	t _r	-	96	-		
Turn-off delay time	t _{d(off)}	-	625	-		
Fall time	t _f	-	102	-		
Gate resistance	R _G	-	1.0	2	Ω	f=1MHz

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}	0.5	0.88	1	V	$V_{GS}=0V, I_{SD}=35A$
Body Diode Reverse Recovery Time	t_{rr}	-	670	1340	ns	$I_{SD}=35A$ $dI/dt=100A/\mu s, V_{DS}=400V$
Body Diode Reverse Recovery Charge	Q_{rr}	-	17.41	35	uC	

Typical Performance Characteristics

Fig 1. Output Characteristics ($T_j=25^\circ\text{C}$)

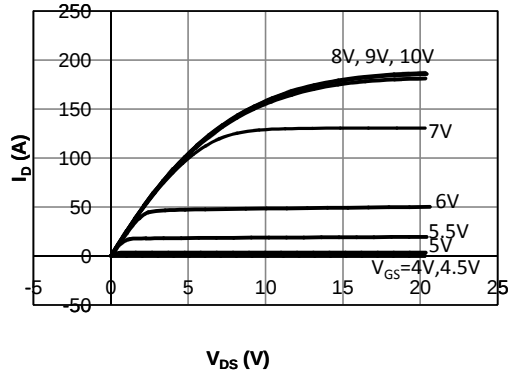


Fig 2. Output Characteristics ($T_j=150^\circ\text{C}$)

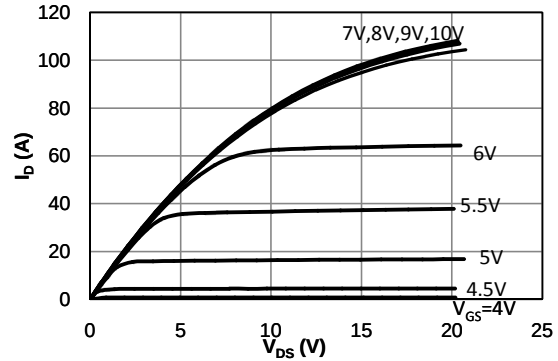


Fig 3: Transfer Characteristics

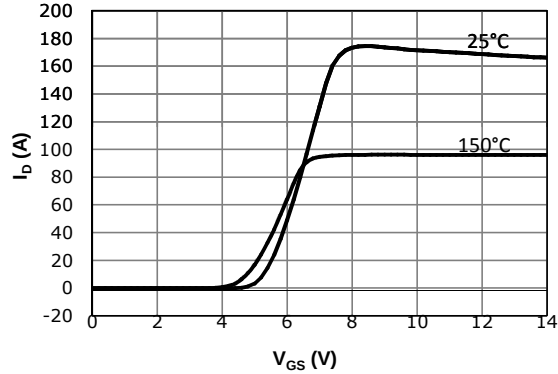


Fig 4: V_{TH} Vs T_j Temperature Characteristics

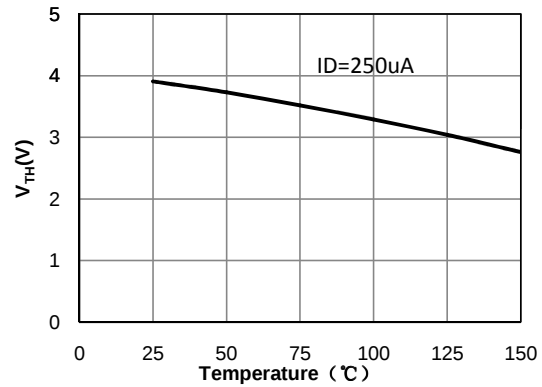


Fig 5: $R_{DS(on)}$ Vs I_{DS} Characteristics ($T_c=25^\circ\text{C}$)

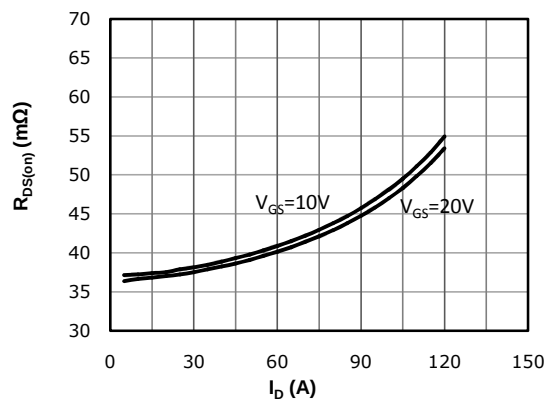


Fig 6: $R_{DS(on)}$ vs. Temperature

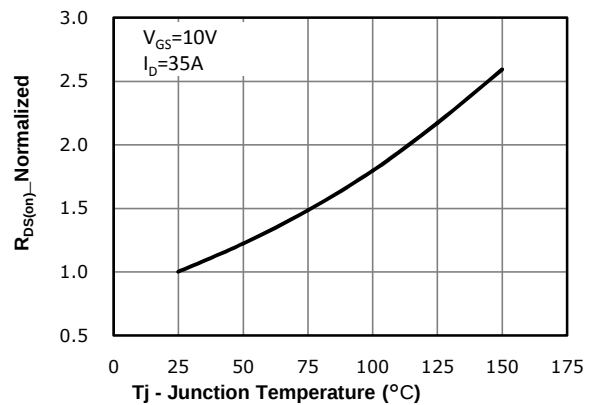


Fig 7: BVDSS vs. Temperature

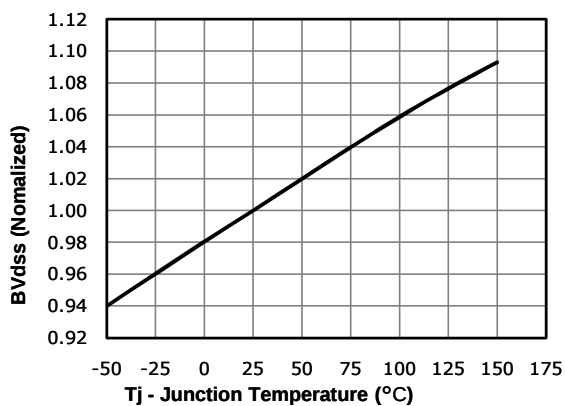


Fig 8: Rds(on) vs Gate Voltage

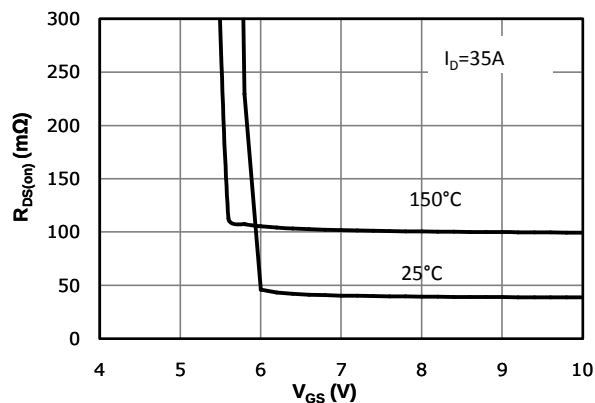


Fig 9: Body-diode Forward Characteristics

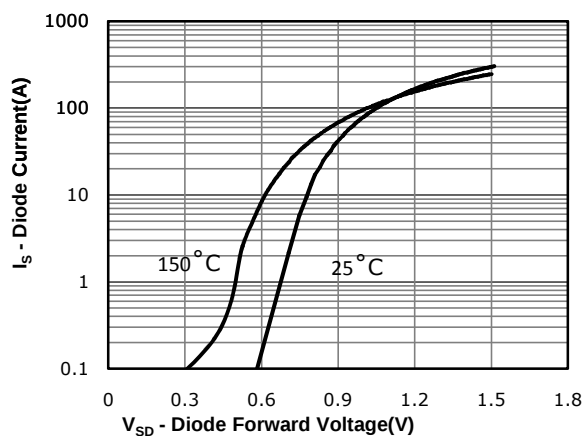


Fig 10: Gate Charge Characteristics

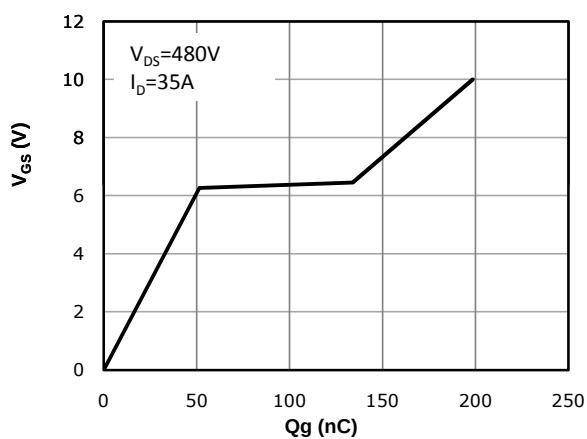


Fig 11: Capacitance Characteristics

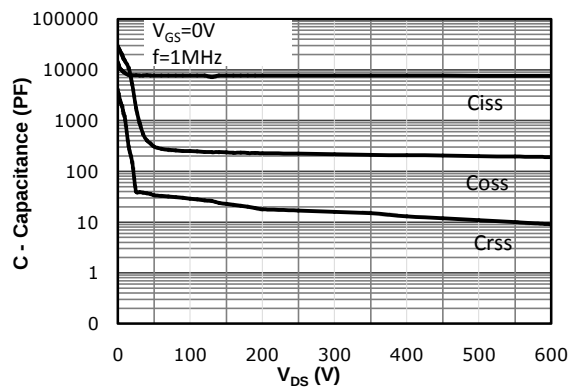


Fig 12: Safe Operating Area

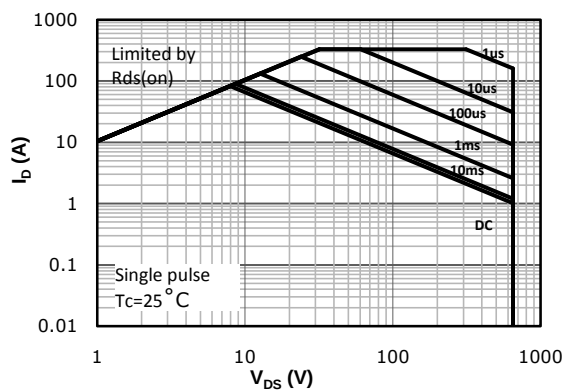
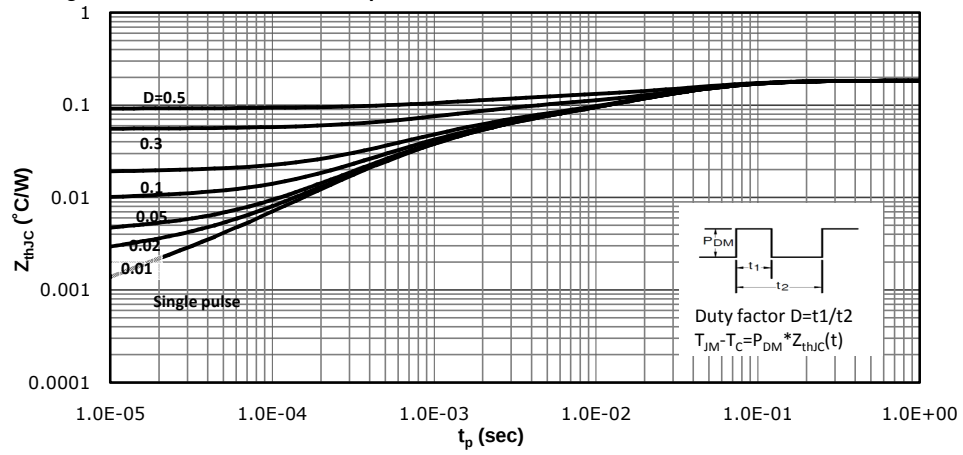
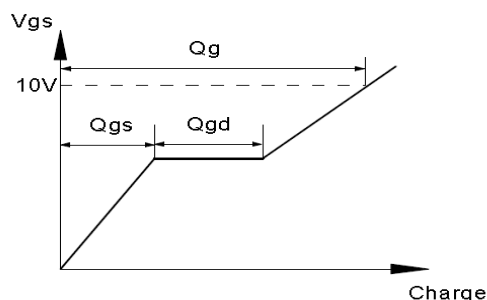
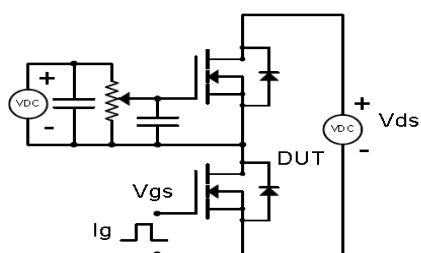


Fig 13: Max. Transient Thermal Impedance

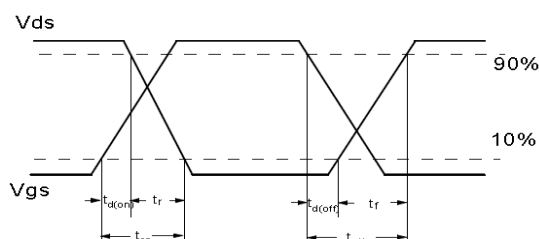
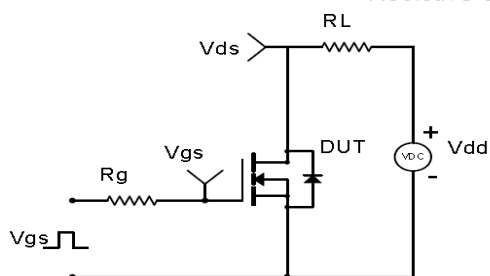


Test Circuit & Waveform

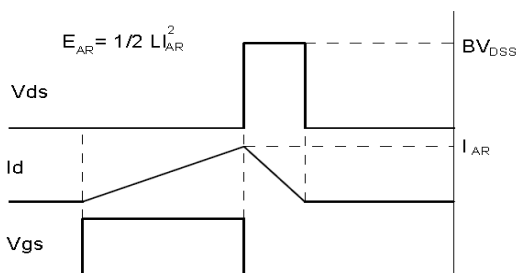
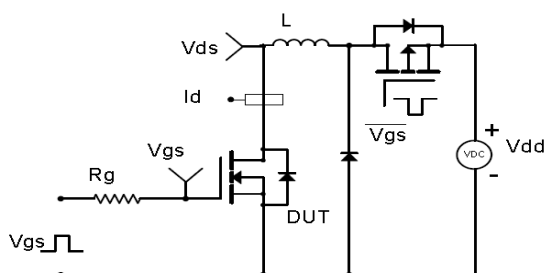
Gate Charge Test Circuit & Waveform



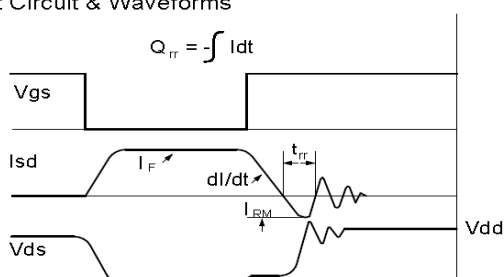
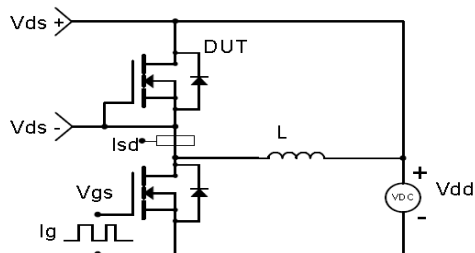
Resistive Switching Test Circuit & Waveforms



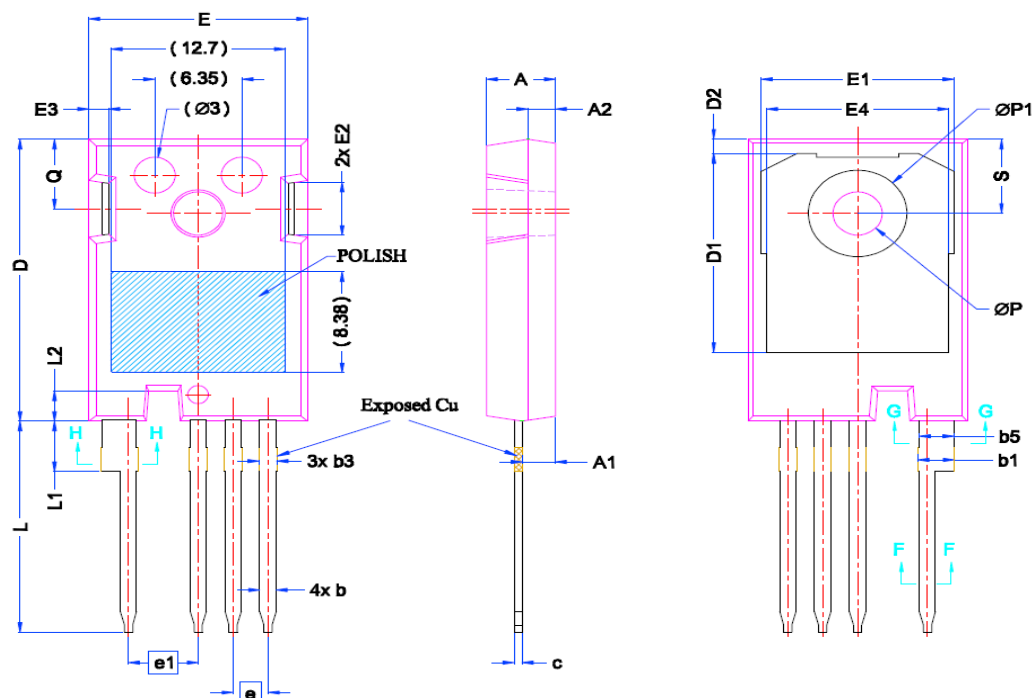
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Package Outline: TO-247-4L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.83	5.21	0.190	0.205
A1	2.29	2.54	0.090	0.100
A2	1.91	2.16	0.075	0.085
b	1.07	1.33	0.042	0.052
b1	2.39	2.94	0.094	0.116
b2	2.39	2.84	0.094	0.112
b3	1.07	1.60	0.042	0.063
b4	1.07	1.50	0.042	0.059
b5	2.39	2.69	0.094	0.106
c	0.55	0.68	0.022	0.027
D	23.30	23.60	0.917	0.929
D1	16.25	17.65	0.640	0.695
D2	0.95	1.25	0.037	0.049
E	15.75	16.13	0.620	0.635
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.00	1.90	0.039	0.075
E4	12.38	13.43	0.487	0.529
e	2.54 BSC		0.100 BSC	
e1	5.08 BSC		0.200 BSC	
L	17.31	17.82	0.681	0.702
L1	3.97	4.37	0.156	0.172
L2	2.35	2.65	0.093	0.104
L3	3.51	3.65	0.138	0.144
Φp1	7.19 REF.		0.283 RES.	
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248

Marking



NOTE:
NXBBAAAAY
X —Assembly location code
BB —Fab code
AAAA —Lot code
Y —Bin code

Revision History

Revision	Date	Major changes
1.2	2021-9-26	Update Ron Spec

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.